

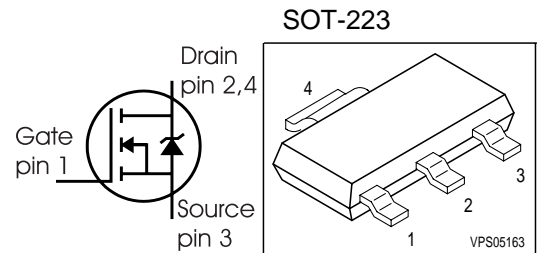
SIPMOS[®] Small-Signal-Transistor

Feature

- N-Channel
- Enhancement mode
- Logic Level
- dv/dt rated

Product Summary

V_{DS}	200	V
$R_{DS(on)}$	1.8	Ω
I_D	0.66	A



Type	Package	Ordering Code	Tape and Reel Information	Marking
BSP297	SOT-223	Q67000-S068	E6327: 3000 pcs/reel	BSP297

Maximum Ratings, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current $T_A=25\text{ }^\circ\text{C}$ $T_A=70\text{ }^\circ\text{C}$	I_D	0.66 0.53	A
Pulsed drain current $T_A=25\text{ }^\circ\text{C}$	$I_{D\text{ puls}}$	2.64	
Reverse diode dv/dt $I_S=0.66\text{A}$, $V_{DS}=160\text{V}$, $di/dt=200\text{A}/\mu\text{s}$, $T_{jmax}=150\text{ }^\circ\text{C}$	dv/dt	6	kV/ μs
Gate source voltage	V_{GS}	± 20	V
ESD Sensitivity (HBM) as per MIL-STD 883		Class 1	
Power dissipation $T_A=25\text{ }^\circ\text{C}$	P_{tot}	1.8	W
Operating and storage temperature	T_j, T_{stg}	-55... +150	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1		55/150/56	

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - soldering point (Pin 4)	R_{thJS}	-	15	25	K/W
SMD version, device on PCB: @ min. footprint @ 6 cm ² cooling area ¹⁾	R_{thJA}	- -	80 48	115 70	

Electrical Characteristics, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain-source breakdown voltage $V_{GS}=0, I_D=250\mu\text{A}$	$V_{(BR)DSS}$	200	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D=400\mu\text{A}$	$V_{GS(th)}$	0.8	1.4	1.8	
Zero gate voltage drain current $V_{DS}=200\text{V}, V_{GS}=0, T_j=25^\circ\text{C}$ $V_{DS}=200\text{V}, V_{GS}=0, T_j=150^\circ\text{C}$	I_{DSS}	- -	- 10	0.1 100	μA
Gate-source leakage current $V_{GS}=20\text{V}, V_{DS}=0$	I_{GSS}	-	1	10	
Drain-source on-state resistance $V_{GS}=4.5\text{V}, I_D=0.53\text{A}$	$R_{DS(on)}$	-	1.2	3	Ω
Drain-source on-state resistance $V_{GS}=10\text{V}, I_D=0.66\text{A}$	$R_{DS(on)}$	-	1	1.8	

¹⁾Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic Characteristics

Transconductance	g_{fs}	$V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$, $I_D = 0.53\text{A}$	0.47	0.94	-	S
Input capacitance	C_{iss}	$V_{GS} = 0, V_{DS} = 25\text{V}$, $f = 1\text{MHz}$	-	286	357	pF
Output capacitance	C_{oss}		-	38	47	
Reverse transfer capacitance	C_{rss}		-	15.7	23.5	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 100\text{V}, V_{GS} = 4.5\text{V}$, $I_D = 0.6\text{A}, R_G = 15\Omega$	-	5.2	7.8	ns
Rise time	t_r		-	3.8	5.7	
Turn-off delay time	$t_{d(off)}$		-	49	74	
Fall time	t_f		-	19	29	

Gate Charge Characteristics

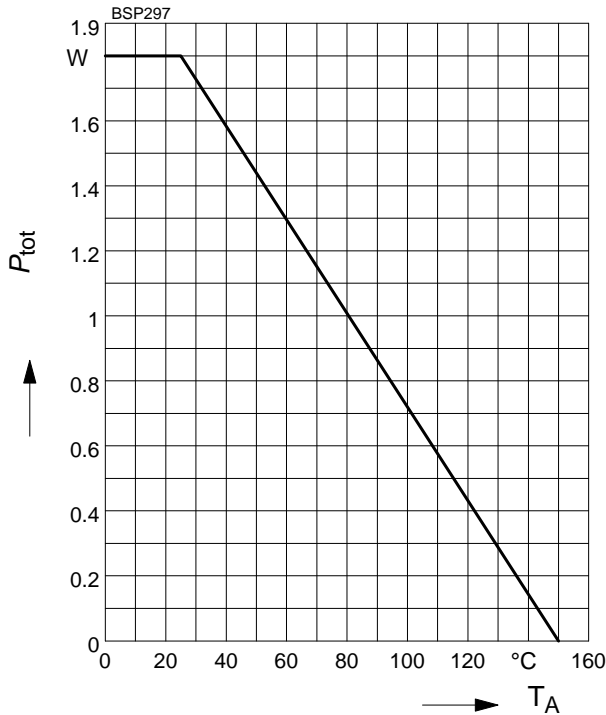
Gate to source charge	Q_{gs}	$V_{DD} = 160\text{V}, I_D = 0.66\text{A}$	-	0.7	0.9	nC
Gate to drain charge	Q_{gd}		-	5.2	7.8	
Gate charge total	Q_g	$V_{DD} = 160\text{V}, I_D = 0.66\text{A}$, $V_{GS} = 0 \text{ to } 10\text{V}$	-	12.9	16.1	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = 160\text{V}, I_D = 0.66\text{A}$	-	2.7	3.3	V

Reverse Diode

Inverse diode continuous forward current	I_S	$T_A = 25\text{ }^\circ\text{C}$	-	-	0.66	A
Inv. diode direct current, pulsed	I_{SM}		-	-	2.64	
Inverse diode forward voltage	V_{SD}	$V_{GS} = 0, I_F = I_S$	-	0.84	1.2	V
Reverse recovery time	t_{rr}	$V_R = 100\text{V}, I_F = I_S$, $di_F/dt = 100\text{A}/\mu\text{s}$	-	52	78	ns
Reverse recovery charge	Q_{rr}		-	80	120	

1 Power dissipation

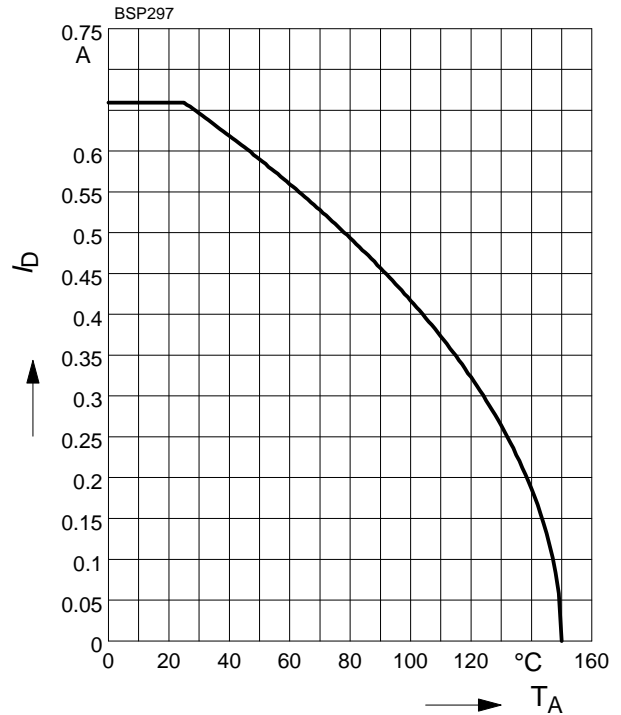
$$P_{\text{tot}} = f(T_A)$$



2 Drain current

$$I_D = f(T_A)$$

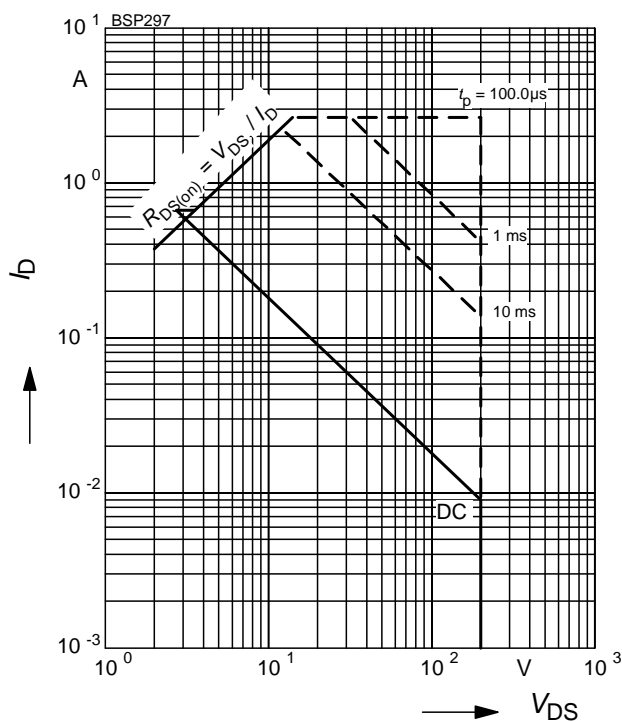
parameter: $V_{GS} \geq 10 \text{ V}$



3 Safe operating area

$$I_D = f(V_{DS})$$

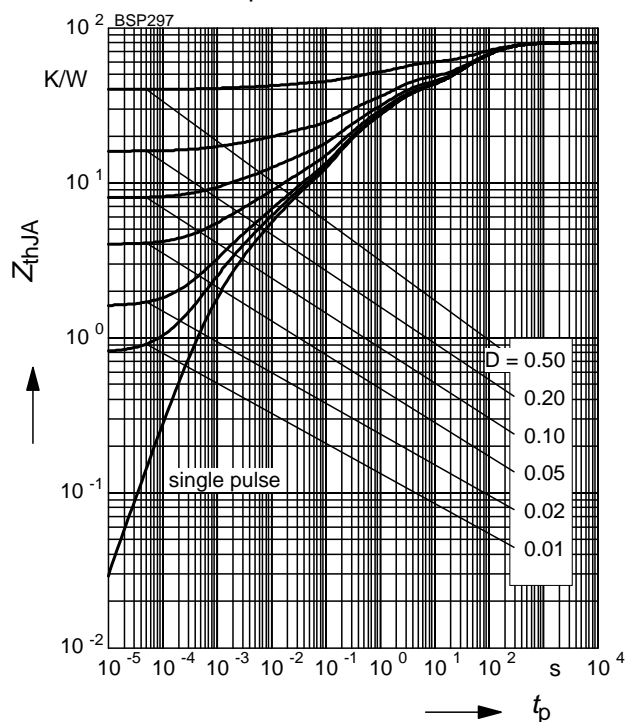
parameter: $D = 0, T_A = 25 \text{ °C}$



4 Transient thermal impedance

$$Z_{\text{thJA}} = f(t_p)$$

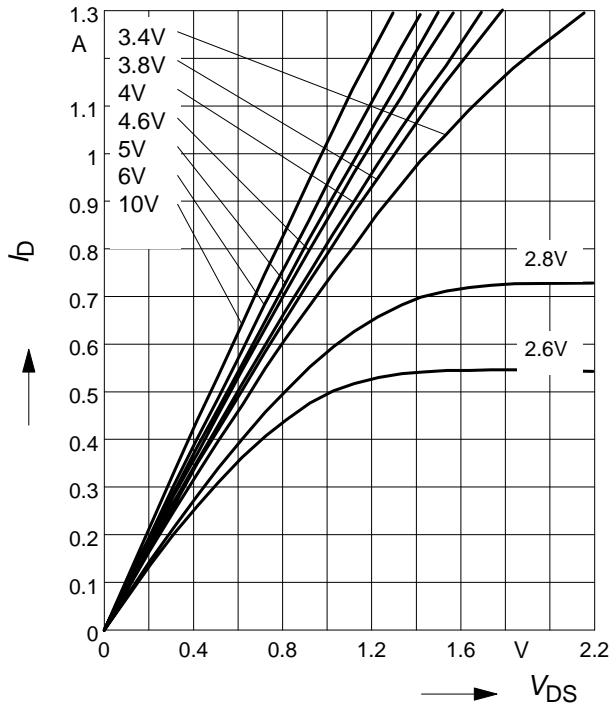
parameter: $D = t_p/T$



5 Typ. output characteristic

$$I_D = f(V_{DS})$$

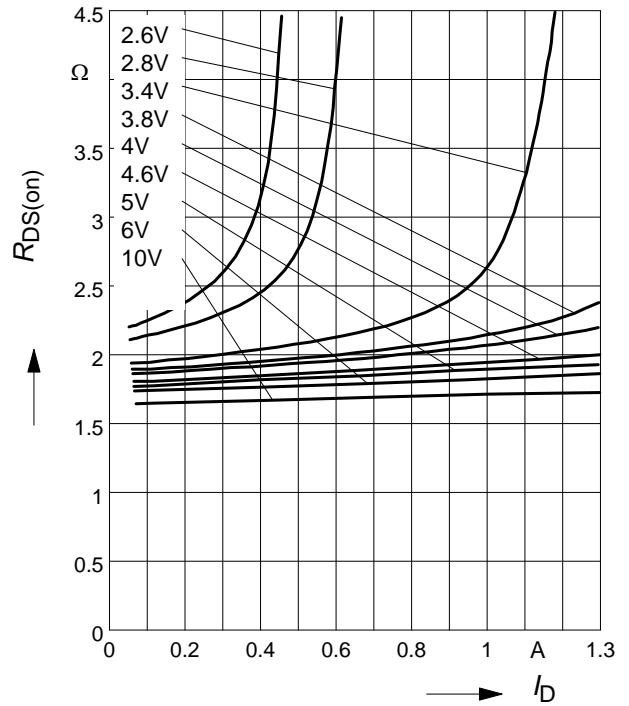
parameter: $T_j = 25\text{ }^\circ\text{C}$, V_{GS}



6 Typ. drain-source on resistance

$$R_{DS(on)} = f(I_D)$$

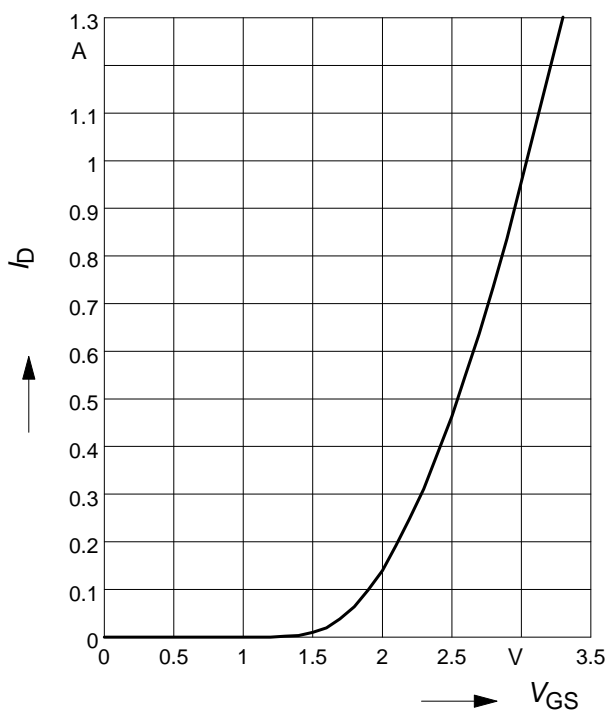
parameter: $T_j = 25\text{ }^\circ\text{C}$, V_{GS}



7 Typ. transfer characteristics

$$I_D = f(V_{GS}); V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$$

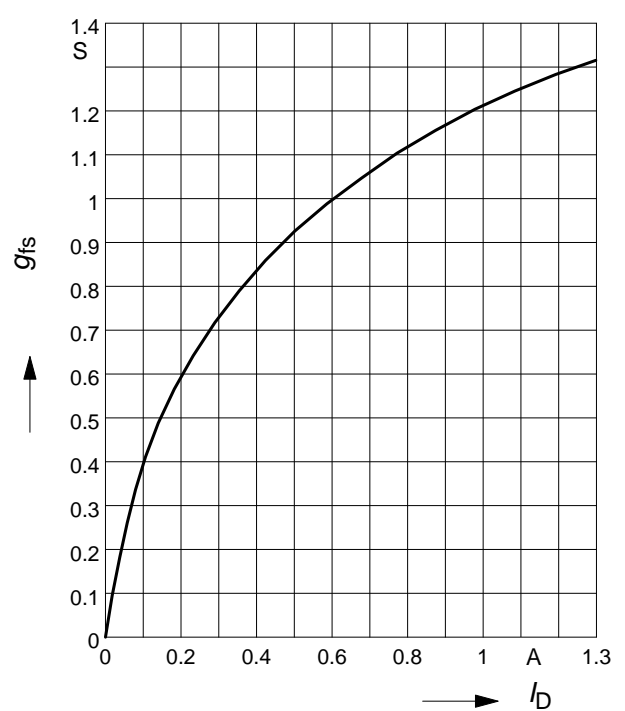
parameter: $T_j = 25\text{ }^\circ\text{C}$



8 Typ. forward transconductance

$$g_{fs} = f(I_D)$$

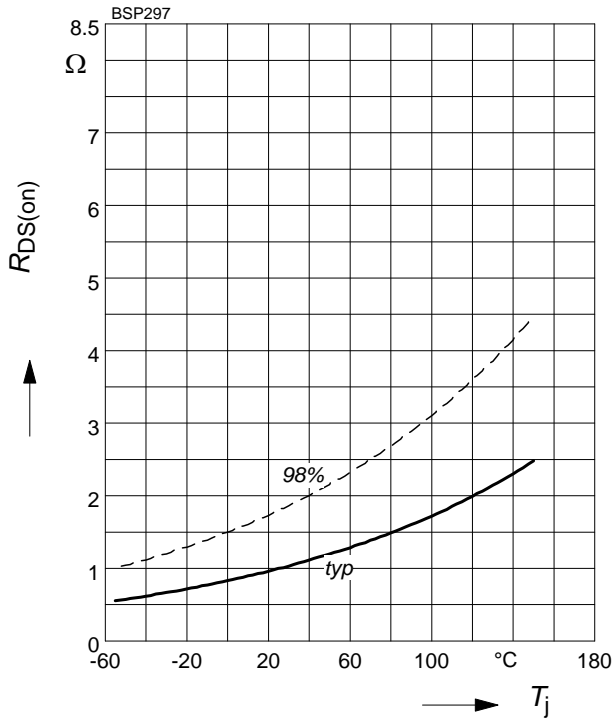
parameter: $T_j = 25\text{ }^\circ\text{C}$



9 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

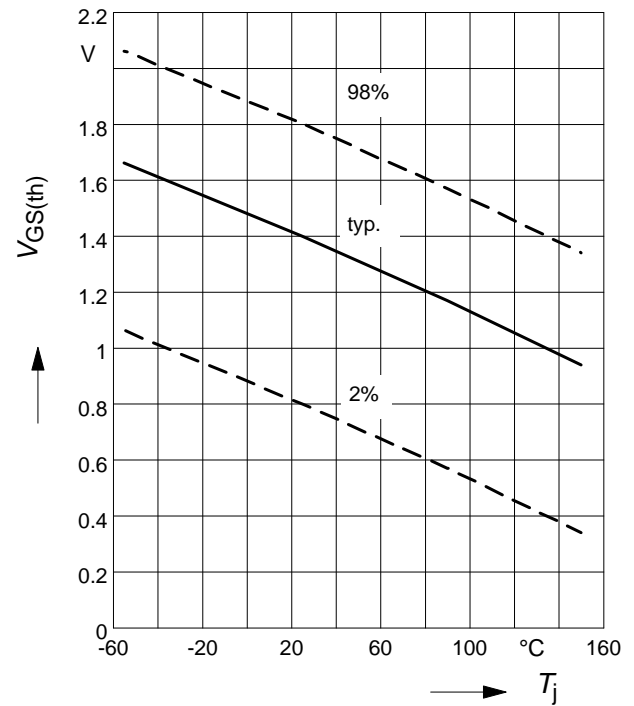
parameter : $I_D = 0.66 \text{ A}$, $V_{GS} = 10 \text{ V}$



10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

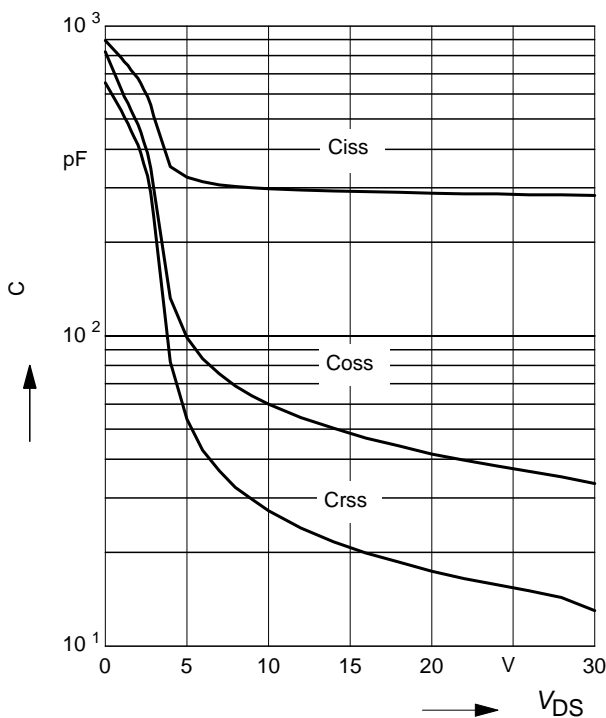
parameter: $V_{GS} = V_{DS}$; $I_D = 400 \mu\text{A}$



11 Typ. capacitances

$$C = f(V_{DS})$$

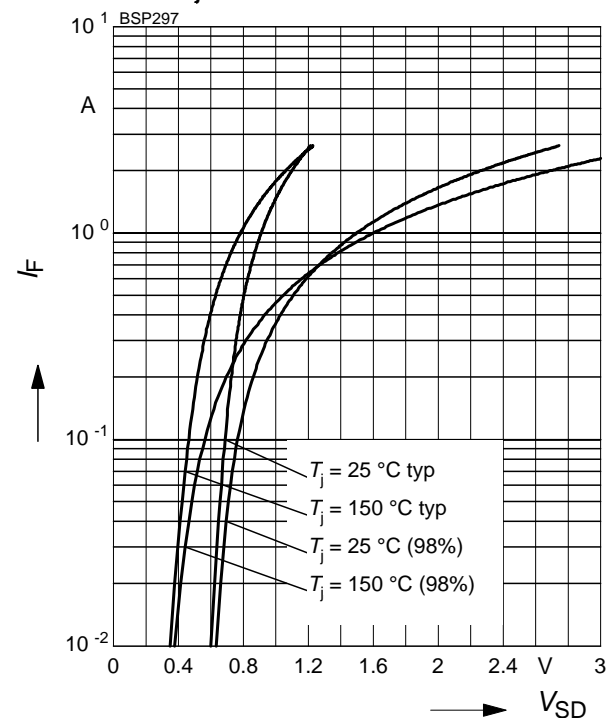
parameter: $V_{GS}=0$, $f=1 \text{ MHz}$, $T_j = 25 \text{ }^\circ\text{C}$



12 Forward character. of reverse diode

$$I_F = f(V_{SD})$$

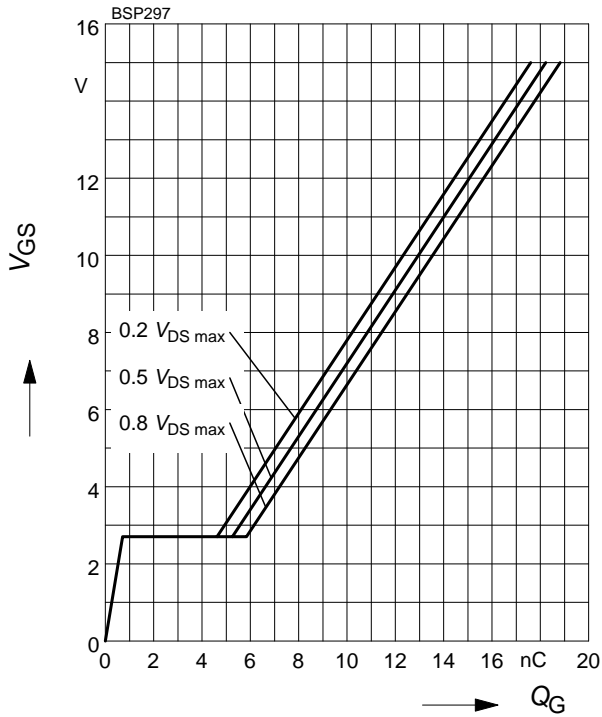
parameter: T_j



13 Typ. gate charge

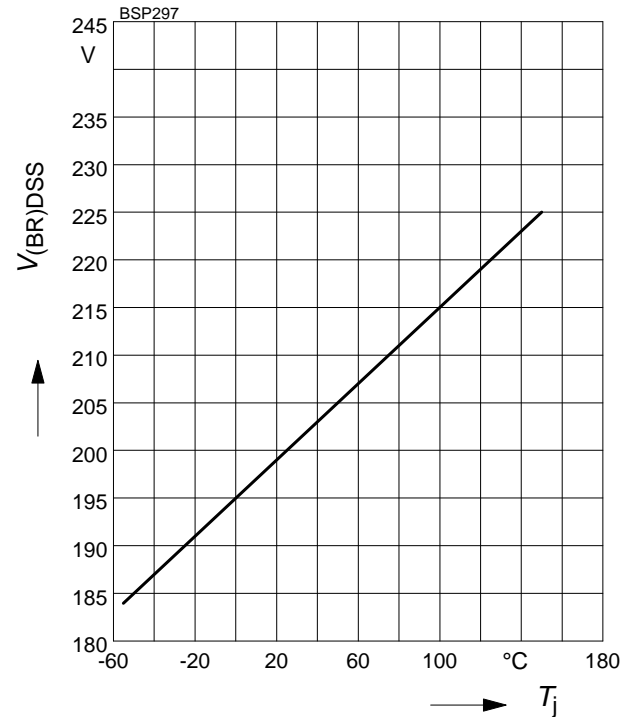
$V_{GS} = f(Q_G)$; parameter: V_{DS} ,

$I_D = 0.66$ A pulsed, $T_j = 25$ °C



14 Drain-source breakdown voltage

$V_{(BR)DSS} = f(T_j)$



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